


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567604	<b>Applicant(s)/Patent Under Reexamination</b>  BAEK, YOON GUN
	<b>Examiner</b>  DANIEL YABUT	<b>Art Unit</b>  3656

SEARCHED			
Class	Subclass	Date	Examiner
74	10R, 10.1, 10.15, 10.2, 553, 554, 555, 556	8/27/2009	Daniel Yabut

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Vinh Luong on class 74	8/18/2009	Daniel Yabut

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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